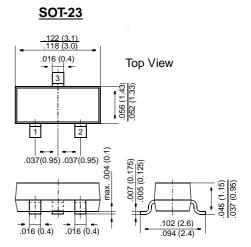


MMBD4148

FEATURES

- Silicon Epitaxial Planar Diode
- · Fast switching diode
- This diode is also available in other case styles including: the DO-35 case with the type designation 1N4148, the Mini-MELF case with type designation LL4148

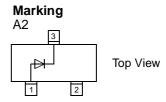


MECHANICAL DATA

- Case: SOT-23 Plastic Package
- Weight: apprax: 0.008gram

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

- Ratings at 25 $^\circ\!\mathrm{C}$ ambient temperature unless otherwise specified



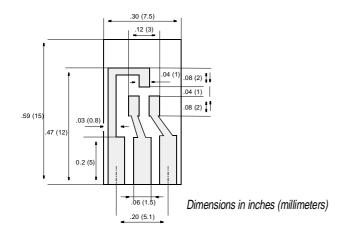
	Symbol	Value	Unit
Reverse Voltage	V _R	75	V
Peak Reverse Voltage	V _{RM}	100	V
Rectified Current (Average) Half Wave Rectification with Resist. Load at $T_{amb} = 25$ °C and $\ge f \ge 50$ Hz	Ι _Ο	150 ¹⁾	mA
Surge Forward Current at t < 1 s and T_j = 25 °C	I _{FSM}	500	mA
Power Dissipation at T _{amb} = 25 °C	P _{tot}	350 ¹⁾	mW
Junction Temperature	Tj	150	°C
Storage Temperature Range	T _S	-65 to +150	°C
¹⁾ Device on fiberglass substrate, see layout			



ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Min.	Тур.	Max.	Unit
Forward Voltage at $I_F = 10 \text{ mA}$	V _F	-	-	1	V
Leakage Current at $V_R = 70 V$ at $V_R = 70 V$, $T_j = 150 °C$ at $V_R = 25 V$, $T_j = 150 °C$	I _R I _R I _R			2.5 50 30	μΑ μΑ μΑ
Capacitance at $V_F = V_R = 0$	C _{tot}	-	-	4	pF
Reverse Recovery Time from I_F = 10 mA to I_R = 10 mA V_R = 6 V, R_L = 100 Ω	t _{rr}	-	-	4	ns
Thermal Resistance Junction to Ambient Air	R _{thJA}	-	-	450 ¹⁾	K/W
¹⁾ Device on fiberglass substrate, see layo	ut				

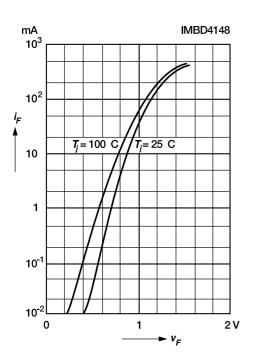


Layout for R_{thJA} test Thickness: Fiberglass 0.059 in (1.5 mm) Copper leads 0.012 in (0.3 mm)

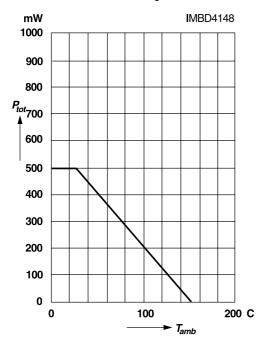


RATINGS AND CHARACTERISTIC CURVES IMBD4148

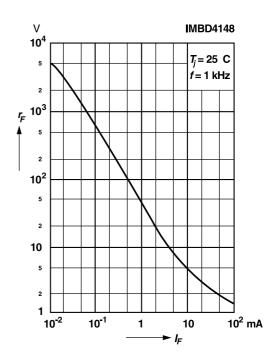
Forward characteristics



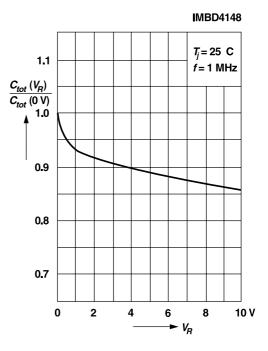
Admissible power dissipation versus ambient temperature For conditions, see footnote in table "Absolute Maximum Ratings"



Dynamic forward resistance versus forward current



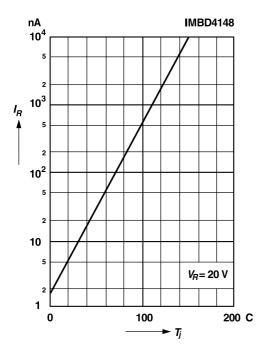
Relative capacitance versus reverse voltage





RATINGS AND CHARACTERISTIC CURVES IMBD4148

Leakage current versus junction temperature



Admissible repetitive peak forward current versus pulse duration For conditions, see footnote in table "Absolute Maximum Ratings"

